



# GL19N40A8

## Silicon N-Channel Power MOSFET

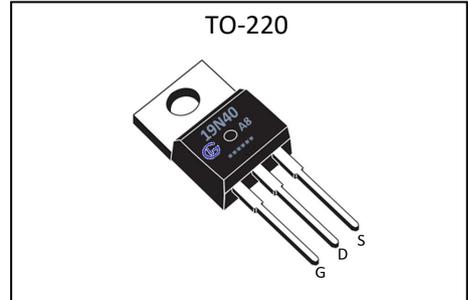
### General Description

GL19N40A8 the silicon N-channel Enhanced VDMOSFET, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-220 which accords with the RoHS standard.

$V_{DSS}$	400	V
$I_D$	19	A
$P_D(T_C=25^\circ C)$	215	W
$R_{DS(ON).TYP.}$	0.225	$\Omega$

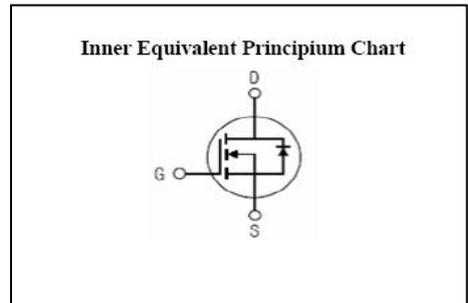
### Features

- Fast Switching
- Low ON Resistance( $R_{dson} \leq 0.25\Omega$ )
- Low Gate Charge (Typical Data:40nC)
- Low Reverse transfer capacitances(Typical:12pF)
- 100% Single Pulse avalanche energy Test



### Applications

- Power switch circuit of adaptor and charger



### Absolute (Tc=25°C unless otherwise specified)

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-to-Source Voltage	400	V
$I_D$	Continuous Drain Current	19	A
	Continuous Drain Current $T_C=100^\circ C$	12	A
$I_{DM}^{a1}$	Pulsed Drain Current	76	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 30$	V
$E_{AS}^{a2}$	Single Pulse Avalanche Energy	750	mJ
$E_{Ar}^{a1}$	Avalanche Energy ,Repetitive	40	mJ
$I_{AR}^{a1}$	Avalanche Current	19	A
$dv/dt^{a3}$	Peak Diode Recovery dv/dt	5.0	V/ns
$P_D$	Power Dissipation	215	W
	Derating Factor above 25°C	1.72	W/°C
$T_J, T_{stg}$	Operating Junction and Storage Temperature Range	150, -55 to 150	°C
$T_L$	Maximum Temperature for Soldering	300	°C

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device



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## Silicon N-Channel Power MOSFET

### Thermal Characteristics

Symbol	Parameter	Rating	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.60	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	$^{\circ}\text{C}/\text{W}$

### Electrical Characteristics (Tc= 25°C unless otherwise specified)

#### OFF Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$V_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	400	--	--	V
$\Delta BV_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	$I_D=250\mu\text{A}, \text{Reference } 25^{\circ}\text{C}$	--	0.46	--	$\text{V}/^{\circ}\text{C}$
$I_{DSS}$	Drain to Source Leakage Current	$V_{DS}=400\text{V}, V_{GS}=0\text{V}, T_a=25^{\circ}\text{C}$	--	--	1.0	$\mu\text{A}$
		$V_{DS}=320\text{V}, V_{GS}=0\text{V}, T_a=125^{\circ}\text{C}$	--	--	10	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+30\text{V}$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-30\text{V}$	--	--	-100	nA

#### ON Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10\text{V}, I_D=9.5\text{A}$	--	0.225	0.25	$\Omega$
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.0	--	4.0	V
$g_{fs}$	Forward Trans conductance	$V_{DS}=15\text{V}, I_D=9.5\text{A}$	--	15	--	S

Pulse width <380 $\mu\text{s}$ ; duty cycle <2%.

#### Dynamic Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=25\text{V}$ $f=1.0\text{MHz}$	--	1900	--	pF
$C_{oss}$	Output Capacitance		--	200	--	
$C_{rss}$	Reverse Transfer Capacitance		--	12	--	

#### Resistive Switching Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D=19\text{A}, V_{DD}=200\text{V}$ $V_{GS}=10\text{V}, R_g=25\Omega$	--	20	--	ns
$t_r$	Rise Time		--	35	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	51	--	
$t_f$	Fall Time		--	55	--	
$Q_g$	Total Gate Charge	$I_D=19\text{A}, V_{DD}=200\text{V}$ $V_{GS}=10\text{V}$	--	40	--	nC
$Q_{gs}$	Gate to Source Charge		--	9	--	
$Q_{gd}$	Gate to Drain ( "Miller" ) Charge		--	15	--	



# GL19N40A8

## Silicon N-Channel Power MOSFET

Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$I_{SD}$	Continuous Source Current (Body Diode)		--	--	19	A
$I_{SM}$	Maximum Pulsed Current (Body Diode)		--	--	76	A
$V_{SD}$	Diode Forward Voltage	$I_S=19A, V_{GS}=0V$	--	--	1.5	V
$t_{rr}$	Reverse Recovery Time	$I_S=19A, T_J=25^{\circ}C$	--	303	--	ns
$Q_{rr}$	Reverse Recovery Charge	$di_F/dt=100A/\mu s, V_{GS}=0V$	--	1867	--	$\mu C$

a1: Repetitive rating; pulse width limited by maximum junction temperature

a2:  $L=10mH, I_D=13A, Start T_J=25^{\circ}C$

a3:  $I_{SD}=19A, di/dt \leq 100A/\mu s, V_{DD} \leq BV_{DS}, Start T_J=25^{\circ}C$



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### Characteristics Curves

Figure 1. On-Region Characteristics

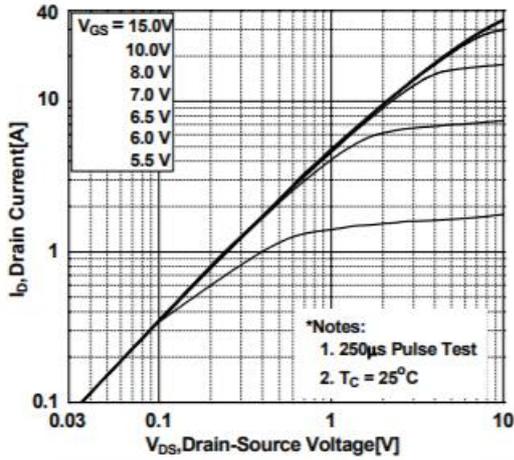


Figure 2. Transfer Characteristics

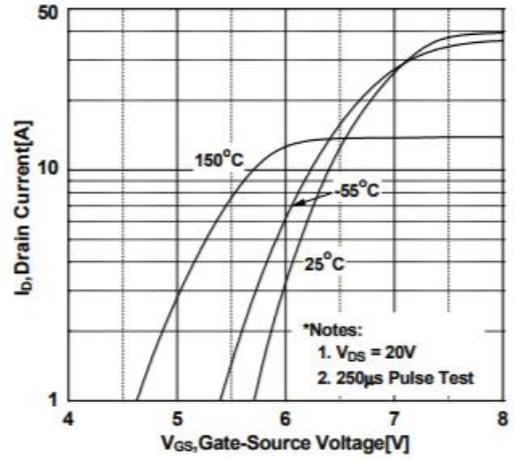


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

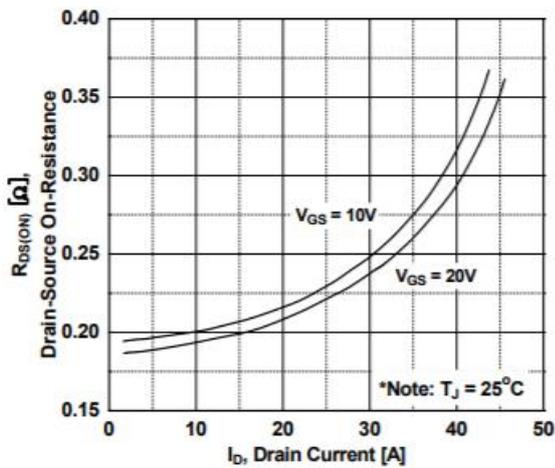


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

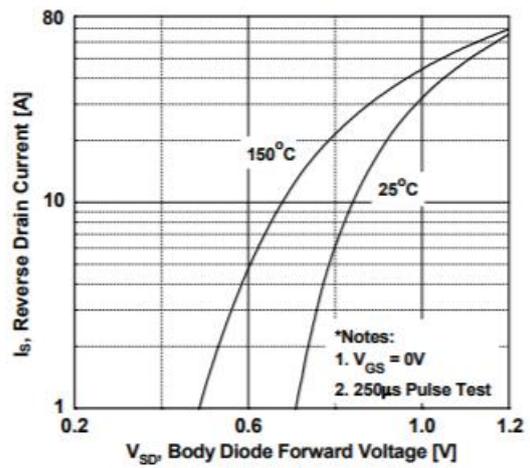


Figure 5. Capacitance Characteristics

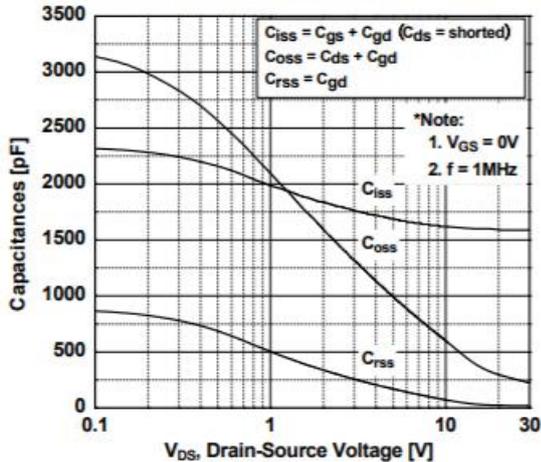
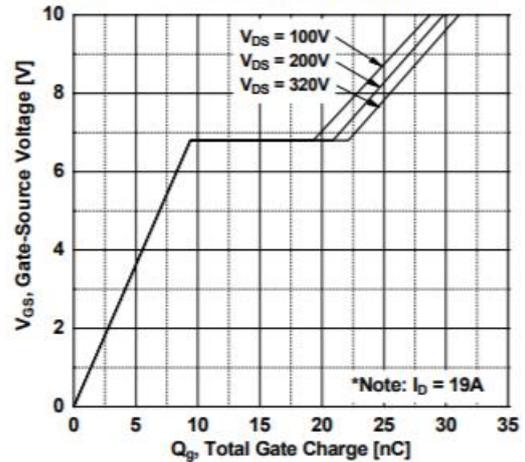


Figure 6. Gate Charge Characteristics





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## Silicon N-Channel Power MOSFET

Figure 7. Breakdown Voltage Variation vs. Temperature

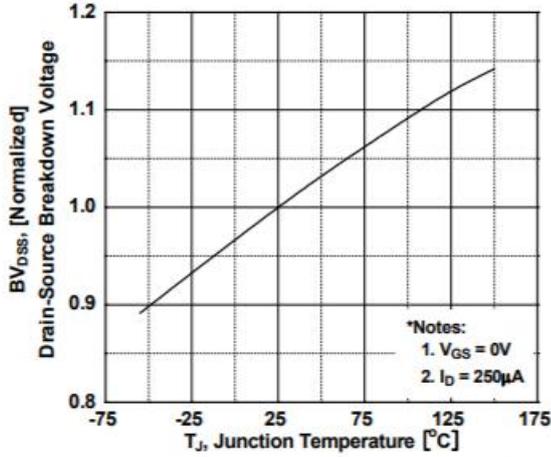


Figure 8. On-Resistance Variation vs. Temperature

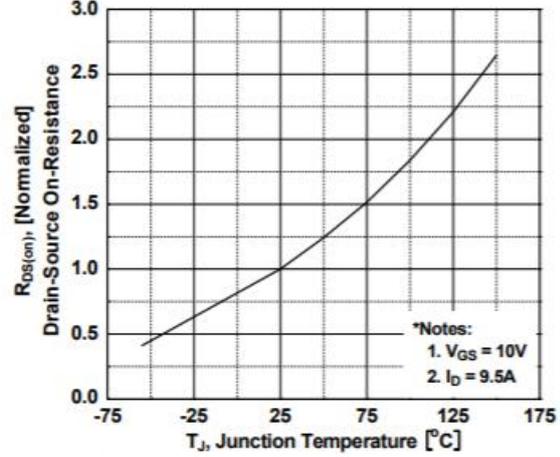


Figure 9. Maximum Safe Operating Area

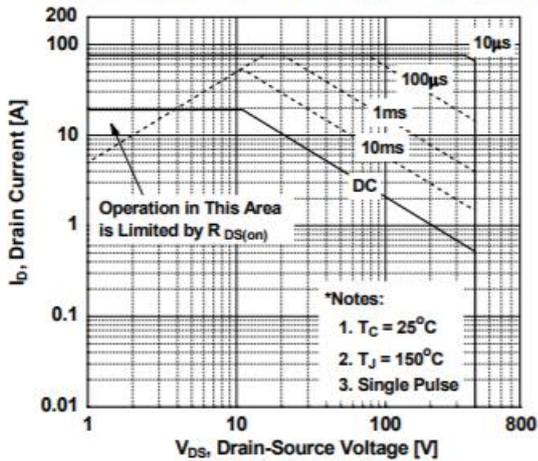


Figure 10. Maximum Safe Operating Area

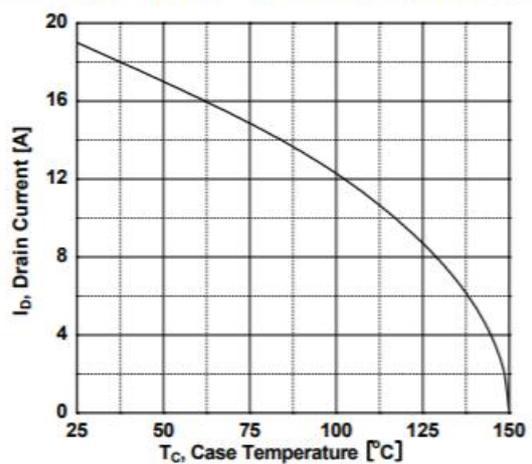


Figure 11. Transient Thermal Response Curve

